

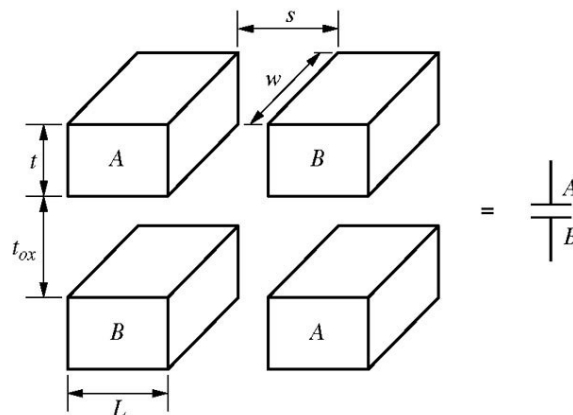
Problem Set #1: Passives & MOS Device & Single-Stage Amplifiers

Problem 1

- (a) If the resistivity of poly-silicon is $10^{-4} \Omega \cdot \text{m}$ and thickness of poly-silicon layer is $1 \mu\text{m}$, calculate the sheet resistance R_{\square} .
- (b) If the distance between two metal layers is 100nm and the space between the two metals is filled with silicon oxide ($\epsilon = 3 \times 10^{-11} \text{ F/m}$), calculate the capacitance per unit area.

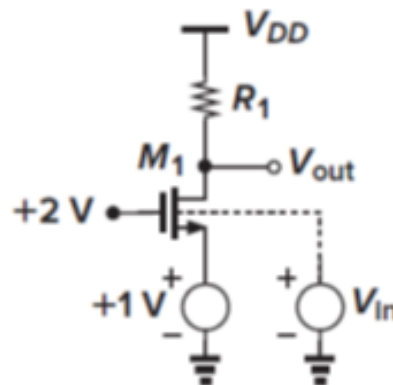
Problem 2

Find the value of the capacitor shown below for $w=300 \mu\text{m}$, $s=t=t_{\text{ox}}=L=1 \mu\text{m}$, and $\epsilon=3 \times 10^{-11} \text{ F/m}$.



Problem 3 (Book 2.8)

Sketch V_{out} as a function of V_{in} as V_{in} varies from 0 to V_{DD} for the circuit shown with $V_{\text{DD}} = 3 \text{V}$, $\mu_n C_{\text{ox}} = 50 \mu\text{A/V}^2$, $V_{\text{TH}} = 0.8 \text{V}$, $2\phi_F = 0.7 \text{V}$, and $\gamma = 0.4 \text{V}^{0.5}$



Problem 4 (Book 2.27)

An NMOS device operating in the sub-threshold region has a ζ of 1.5. What variation in V_{GS} results in a tenfold change in I_D ? If $I_D=10\mu A$, calculate g_m .

Problem 5 (Book 2.13 & 2.14)

(a) Show that the transit frequency of a MOS device is given by:

$$f_T = \frac{g_m}{2\pi(C_{GD} + C_{GS})}$$

(b) Calculate the transit frequency for a device in sub-threshold region (weak inversion) and compare that with the result obtained in (a).

Problem 6

For the source-follower circuit shown, M_1 and M_2 are identical.

$\mu_n C_{ox}=50\mu A/V^2$, $(W/L)=2\mu m/1\mu m$, $V_{TH} = 0.8V$, and $V_b = 2V$, $\lambda = 0.02V^{-1}$, Find:

(a) Gain ($=V_{out}/V_{in}$) and G_m if $\gamma=0$.

Repeat if body effect is not neglected ($\gamma=0.4$).

(b) R_{out} if $\gamma=0$. Repeat if body effect is not neglected ($\gamma=0.4$).

(c) Poles at the input and output. $C_{ox}=10fF/\mu m^2$ and $C_{ov}=1fF/\mu m$

Assume $R_S=100\Omega$ and $C_L=10pF$. Consider C_{gs} and C_{gd} only and use Miller theory.

